

Product Change Notification: CAAN-27VKXJ630

Date:

09-Apr-2025

Product Category:

8-Bit Microcontrollers, Capacitive Touch Sensors

Notification Subject:

CCB 6849 Final Notice: Qualification of STA as an additional assembly site for selected AT42QT1x, AT42QT21, AT42QT41, ATmega16, ATmega32, ATmega48, ATmega8x, ATtiny26, ATtiny46, ATtiny8x, QT60160 and QT60240 device families available in 32L VQFN (5x5x1mm) package.

Affected CPNs:

CAAN-27VKXJ630_Affected_CPN_04092025.pdf CAAN-27VKXJ630_Affected_CPN_04092025.csv

PCN Status: Final Notification

PCN Type: Manufacturing Change

Microchip Parts Affected: Please open one of the files found in the Affected CPNs section. Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

Description of Change: Qualification of STA as an additional assembly site for selected AT42QT1x, AT42QT21, AT42QT41, ATmega16, ATmega32, ATmega48, ATmega8x, ATtiny26, ATtiny46, ATtiny8x, QT60160 and QT60240 device families available in 32L VQFN (5x5x1mm) package.

Pre and Post Summary Changes:

	Pre C	hange	Post C	Change			
Assembly Site	Test (Shanghai) Co., LTD		Amkor Assembly & Test (Shanghai) Co., LTD (ANAC)		STATS Chippac Ltd. (STA)		
Wire Material	Au	CuPd	Au	CuPd	Au	CuPdAu	

Die Attach Material	8290	8290	EN4900GC			
Molding Compound Material	G700	G700	G700E			
Lead-Frame Material	C194	C194	C194			
Lead-Frame Paddle Size	146X146mils	146X146mils	138X138mils			
Lead-Frame Lead Lock	No	No	Yes			
Lead-Frame Design	See Pre and Post Change Summary					

Impacts to Datasheet: None

Change Impact: None

Reason for Change: To improve on time delivery performance by qualifying STA as an additional

assembly site.

Change Implementation Status: In Progress

Estimated First Ship Date: 09 May 2025 (date code: 2519)

Note Below EFSD: Note: Please be advised that after the estimated first ship date customers may

receive pre and post change parts.

Timetable Summary:

	March 2024				April 2025			May 2025							
Work Week	10	11	12	13	14	_	14	15	16	17	18	19	20	21	22
Initial PCN Issue Date	X														
Qual Report Availability								X							
Final PCN Issue Date								X							
Estimated Implementation Date												X			

Method to Identify Change: Traceability Code

Qualification Report: Please open the attachments included with this PCN labeled as PCN # Qual Report.

Revision History: March 04, 2024: Issued initial notification.

June 25, 2024: Re-issued initial notification. Updated Die attach material from 8290 to EN4900GC. Updated affected part list to remove catalog part number ATTINY861A-MU based on the updated scope. Updated qual plan to reflect the die attach material change and include wire sweep test. April 09, 2025: Issued final notification. Attached Qualification Report. Provided Estimated First Ship Date on May 09, 2025.

Note: The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable product.

Attachments:

PCN_CAAN-27VKXJ630_Pre and Post Change Summary.pdf PCN_CAAN-27VKXJ630_Qualification Report.pdf

Please contact your local **Microchip sales office** with questions or concerns regarding this notification.

Terms and Conditions:

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If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

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Affected Catalog Part Numbers (CPN)

AT42QT1110-MUR

AT42QT1244-MU

AT42QT1244-MUR

AT42QT1245-MU

AT42QT1245-MUR

AT42QT2100-MUR

AT42QT4160-MUR

ATMEGA168-20MQ

ATMEGA168-20MQR

ATMEGA168-20MU

ATMEGA168-20MUR

ATMEGA168A-MU

ATMEGA168A-MUR

ATMEGA168P-20MQ

ATMEGA168P-20MQR

ATMEGA168P-20MU

ATMEGA168P-20MUR

ATMEGA168PA-MN

ATMEGA168PA-MNR

ATMEGA168PA-MURA2

ATMEGA168PV-10MU

ATMEGA168PV-10MUR

ATMEGA168V-10MQ

ATMEGA168V-10MQR

ATMEGA168V-10MQR610

ATMEGA168V-10MU

ATMEGA168V-10MUR

Date: Tuesday, April 8, 2025

CAAN-27VKXJ630 - CCB 6849 Final Notice: Qualification of STA as an additional assembly site for selected AT42QT1x, AT42QT21, AT42QT41, ATmega16, ATmega32, ATmega48, ATmega8x, ATtiny26, ATtiny46, ATtiny8x, QT60160 and QT60240 device families available in 32L VQFN (5x5x1mm) package. ATMEGA168V-10MUR598 ATMEGA328-MU ATMEGA328-MUR ATMEGA328P-MN ATMEGA328P-MNR ATMEGA328P-MUA2 ATMEGA48-20MU ATMEGA48-20MUR ATMEGA48A-MU ATMEGA48A-MUR ATMEGA48P-20MU ATMEGA48P-20MUR ATMEGA48PA-MN ATMEGA48PA-MNR ATMEGA48PV-10MU ATMEGA48PV-10MUR ATMEGA48V-10MU ATMEGA48V-10MUR ATMEGA48V-10MURA3 ATMEGA8-16MU ATMEGA8-16MUR ATMEGA88-20MU ATMEGA88-20MUR ATMEGA88A-MU ATMEGA88A-MUR ATMEGA88P-20MU ATMEGA88P-20MUR ATMEGA88PA-MN ATMEGA88PA-MNR

Date: Tuesday, April 8, 2025

ATMEGA88PA-MURA6

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Date: Tuesday, April 8, 2025

CAAN-27VKXJ630 - CCB 6849 Final Notice: Qualification of STA as an additional assembly site for selected AT42QT1x, AT42QT21, AT42QT41, ATmega16, ATmega32, ATmega48, ATmega8x, ATtiny26, ATtiny46, ATtiny8x, QT60160 and QT6024 device families available in 32L VQFN (5x5x1mm) package.
QT60160-ISG
QT60240-ISG
Date: Tuesday, April 8, 2025

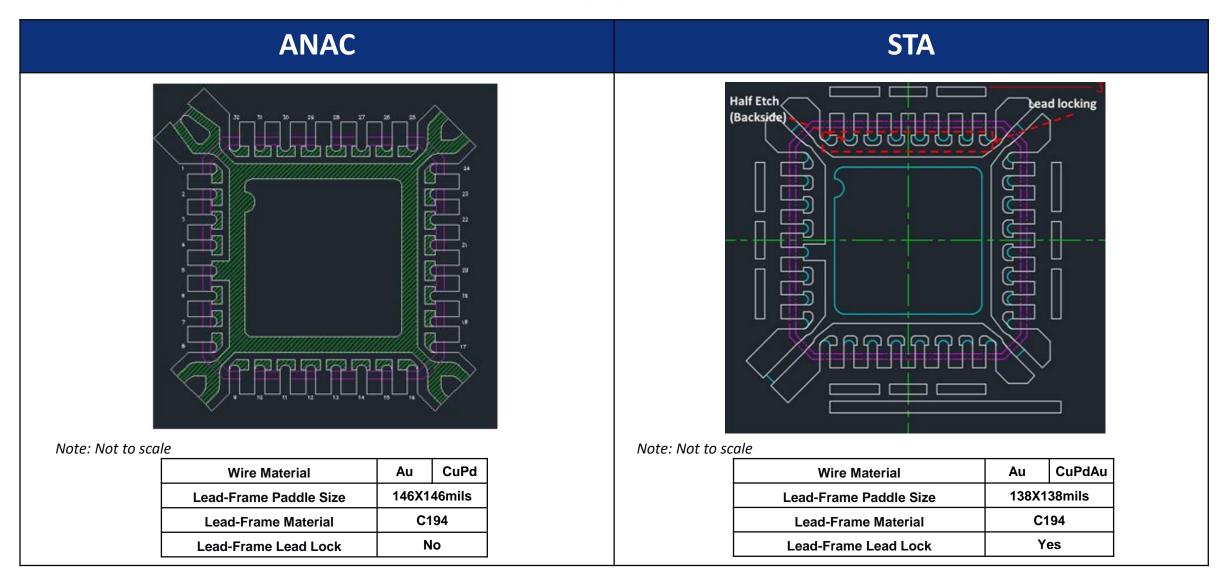
CCB 6849 Pre and Post Change Summary PCN #: CAAN-27VKXJ630



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LEAD FRAME COMPARISON







QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN #: CAAN-27VKXJ630

Date: March 31, 2025

Qualification of STA as an additional assembly site for selected AT42QT1x, AT42QT21, AT42QT41, ATmega16, ATmega32, ATmega48, ATmega8x, ATtiny26, ATtiny46, ATtiny8x, QT60160 and QT60240 device families available in 32L VQFN (5x5x1mm) package.



Purpose:

Qualification of STA as an additional assembly site for selected AT42QT1x, AT42QT21, AT42QT41, ATmega16, ATmega32, ATmega48, ATmega8x, ATtiny26, ATtiny46, ATtiny8x, QT60160 and QT60240 device families available in 32L VQFN (5x5x1mm)

package.

CCB No.: 6849

	Assembly site	STA		
	BD Number	BD-002159-03		
	MP Code (MPC)	355E77S4BC04		
	Part Number (CPN)	ATMEGA168-20MU		
Misc.	MSL information	MSL1		
	Assembly Shipping Media (T/R, Tube/Tray)	Tray		
	Base Quantity Multiple (BQM)	490		
	Reliability Site	MPHIL		
	Paddle size	138X138mils		
	Exposed Pad size	122X122 mils		
	Material	C194		
	DAP Surface Prep	Ring		
	Treatment	Roughened		
<u>Lead-Frame</u>	Process	Etched		
	Lead-lock	Yes		
	Part Number	R002-A232X		
	Lead Plating	Matte Sn		
	Strip Size	250*70mm		
	Strip Density	216 units/strip		
Bond Wire	Material	CuPdAu		
Dio Attach	Part Number	EN4900GC		
<u>Die Attach</u>	Conductive	Yes		
<u>MC</u>	Part Number	G700E		
	Package Type	VQFN		
<u>PKG</u>	Pin/Ball Count	32L		
1110	PKG width/size	5X5X1mm		



	Manufact	urina	Infor	mation:
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Assembly Lot No.
2441A5D/STA-252800006.000
2441A5M/STA-252800007.000
2441A5T/STA-252800008.000

X	Pass	Fail	
]		

Qualification of 355E7 MCSO 350nm mask in 32L VQFN 5x5x1mm CuPdAu 0.8 mil wire at STA is qualified Moisture/ Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard. Pre-Conditioning, HAST, UHAST, TCT and HTSL Passed.

Package Qualification Report									
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks			
Precondition Prior Perform Reliability Tests	External Visual inspection System: Luxo Lamp	JESD22- A113 JIP/ IPC/JEDE C J-STD- 020E	693(0)	0/693	Pass	Good Devices			
MSL-1 @ 260°C	Bake: 150°C, 24hrs System: HERAEUS Moisture Soak: 85°C/85%RH Moisture Soak 168hrs. System: Climats Excal 5423-HE Reflow: 3x Convection-Reflow 260°C max System: Mancorp CR.5000F	231 units per Lot	693(0) 693(0) 693(0)						
	Electrical Test: 25°C, 85°C ATE Testing: AMKOR, Shanghai		693(0)	0/693	Pass				

Test Number	Test Condition	Standard/	Qty.	Def/SS	Result	Remarks
(Reference)	Test Condition	Method	(Acc.)	D01/00	rtoodit	Romano
			, ,			
	Stress Condition:	JESD22-	231(0)			Parts had been
Temp Cycle	-65°C to +150°C, 500 Cycles	A104				pre-conditioned at
	System: VOTSCH VT 7012 S2					260°C
			004(0)	0/004	_	
	Electrical Test: 85°C AMKOR, Shanghai		231(0)	0/231	Pass	
	•					
	Bond Strength: Wire Pull (min. bond strength of 3gram)		30bonds	0/30		
	where all (min. bond strength of Sgrain)		(0)	0/00		
	Stress Condition:	JESD22-	231(0)			Parts had been
UHAST	+130°C/85%RH, 96H	A110	201(0)			pre-conditioned at
	System: HIRAYAMA HASTEST PC-422R8	711.0				260°C
			004(0)	0/004	_	
	Electrical Test: 25°C		231(0)	0/231	Pass	
	AMKOR, Shanghai					
	Stress Condition:	JESD22-	231(0)			Parts had been
HAST	+130°C/85%RH, 96H	A118				pre-conditioned at
	System: HIRAYAMA HASTEST PC-422R8					260°C
	Electrical Test: 25°C, 85°C		231(0)	0/231	Pass	
	AMKOR, Shanghai		- (-)			
	Stress Condition:	JESD22-	45 (0)			
HTSL	Bake 175°C, 504H	A103	10 (0)			
	System: HERAEUS					
			45 (0)	0/45	Dana	
	Electrical Test: 25°C, 85°C AMKOR, Shanghai		45 (0)	0/45	Pass	
	AWKOK, Shanghai					
Solderability	Bake: Temp 155°C,4Hrs	J-STD-002	22 (0)	0/22	Pass	
Temp 245°C	System: Oven					
	Solder Bath: Temp.245°C					
	Wire Pull	M2011.8	30(0)	0/30	Pass	
	1 lot, 30 bonds from 5 units min	MIL-STD-	bonds			
Bond Strength		883				
Bond Sirengin	Bond Shear	M2011.8	20(0)	0/30	Pass	
	1 lot, 20 bonds from 5 units min	MIL-STD-	bonds	5,00	1 400	
	,	883				